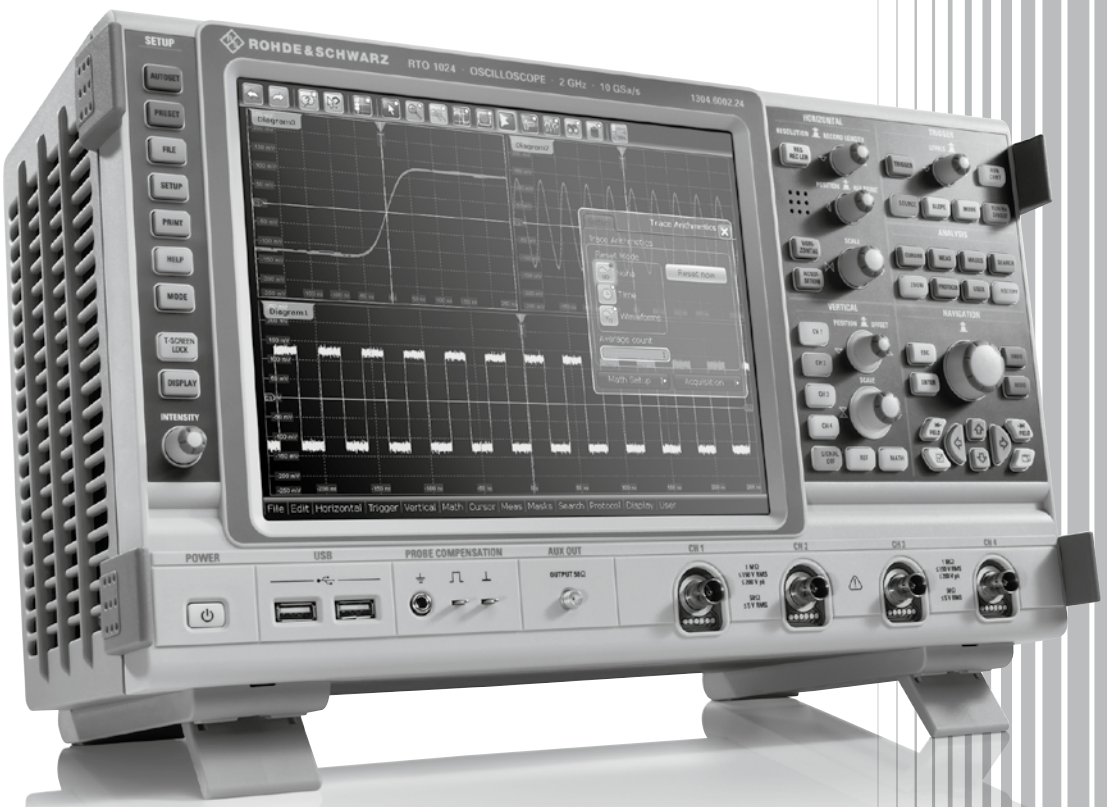
R&S®RTO
Digital Oscilloscopes
Specifications



ROHDE&SCHWARZ

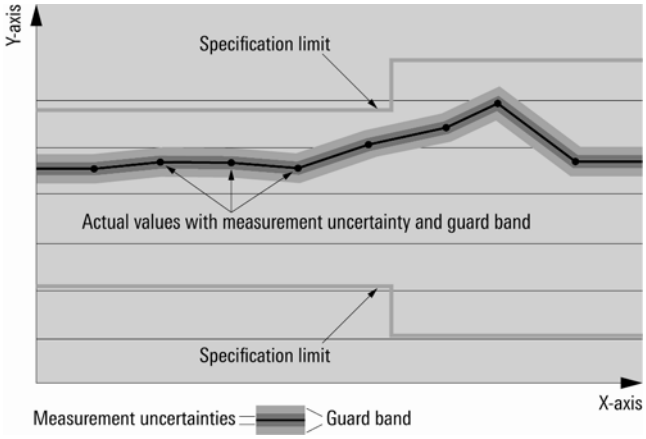
CONTENTS

Definitions

General
Product data applies under the following conditions:

- Three hours storage at ambient temperature followed by 30 minutes warm-up operation
- Specified environmental conditions met
- Recommended calibration interval adhered to
- All internal automatic adjustments performed, if applicable

Specifications with limits
Represent warranted product performance by means of a range of values for the specified parameter. These specifications are marked with limiting symbols such as <, ≤, >, ≥, ±, or descriptions such as maximum, limit of, minimum. Compliance is ensured by testing or is derived from the design. Test limits are narrowed by guard bands to take into account measurement uncertainties, drift and aging, if applicable.



Specifications without limits
Represent warranted product performance for the specified parameter. These specifications are not specially marked and represent values with no or negligible deviations from the given value (e.g. dimensions or resolution of a setting parameter). Compliance is ensured by design.

Typical data (typ.)
Characterizes product performance by means of representative information for the given parameter. When marked with <, > or as a range, it represents the performance met by approximately 80 % of the instruments at production time. Otherwise, it represents the mean value.

Nominal values (nom.)
Characterize product performance by means of a representative value for the given parameter (e.g. nominal impedance). In contrast to typical data, a statistical evaluation does not take place and the parameter is not tested during production.

Measured values (meas.)
Characterize expected product performance by means of measurement results gained from individual samples.

Uncertainties
Represent limits of measurement uncertainty for a given measurand. Uncertainty is defined with a coverage factor of 2 and has been calculated in line with the rules of the Guide to the Expression of Uncertainty in Measurement (GUM), taking into account environmental conditions, aging, wear and tear.

Typical data as well as nominal and measured values are not warranted by Rohde & Schwarz.

Base unit

Vertical system

Input channels	R&S®RTO1012	2 channels
	R&S®RTO1014	4 channels
	R&S®RTO1022	2 channels
	R&S®RTO1024	4 channels
Input impedance		50 Ω ± 2 % (50 Ω ± 1.5 % from +15 °C to +30 °C), 1 MΩ ± 1 % || 15 pF (meas.)
Analog bandwidth (–3 dB)	at 50 Ω input impedance	
	R&S®RTO1012 and R&S®RTO1014	1 GHz
	R&S®RTO1022 and R&S®RTO1024	2 GHz
	at 1 MΩ input impedance	500 MHz (meas.)
Analog bandwidth limits	max. –1.5 dB, min. –4 dB	200 MHz, 20 MHz
Rise time/fall time	10 % to 90 % at 50 Ω (calculated)	
	R&S®RTO1012 and R&S®RTO1014	300 ps
	R&S®RTO1022 and R&S®RTO1024	175 ps
Input VSWR		1.25 (meas.)
Vertical resolution		8 bit
Effective number of bits of digitizer	for full-scale sine-wave signal with frequency equal or lower than –3 dB bandwidth	>7.0 bit (meas.)
DC gain accuracy	offset and position set to 0 V, after self-alignment	
	at 50 Ω, input sensitivity > 5 mV/div	±1.5 %
	at 50 Ω, input sensitivity ≤ 5 mV/div	±2 %
	at 1 MΩ	±2 %
Input coupling	at 50 Ω	DC and GND
	at 1 MΩ	DC, AC and GND
Input sensitivity	at 50 Ω	1 mV/div to 1 V/div
	at 1 MΩ	1 mV/div to 10 V/div
Maximum input voltage	at 50 Ω	5 V (RMS)
	at 1 MΩ	150 V (RMS), 200 V (V_p), derates at 20 dB/decade to 5 V (RMS) above 250 kHz
Position range		±5 div
Offset range at 50 Ω	input sensitivity	
	316 mV/div to ≤ 1 V/div	±10 V
	100 mV/div to ≤ 316 mV/div	±3 V
	1 mV/div to ≤ 100 mV/div	±1 V
Offset range at 1 MΩ	input sensitivity	
	3.16 V/div to ≤ 10 V/div	± (115 V – input sensitivity × 5 div)
	1 V/div to ≤ 3.16 V/div	±100 V
	316 mV/div to ≤ 1 V/div	± (11.5 V – input sensitivity × 5 div)
	100 mV/div to ≤ 316 mV/div	±10 V
	31.6 mV/div to ≤ 100 mV/div	± (1.15 V – input sensitivity × 5 div)
	1 mV/div to ≤ 31.6 mV/div	±1 V
Offset accuracy		±(0.35 % × |net offset| + 2.5 mV + 0.1 div × input sensitivity) (net offset = offset – position × input sensitivity)
DC measurement accuracy	after adequate suppression of measurement noise by means of either high-resolution sampling mode, waveform averaging, or a combination of both	±(DC gain accuracy × |reading – net offset| + offset accuracy)
Channel-to-channel isolation		> 60 dB

RMS noise floor at 50 Ω (meas.)	input sensitivity	R&S®RTO1012, R&S®RTO1014	R&S®RTO1022, R&S®RTO1024
	1 mV/div	0.16 mV	0.15 mV
	2 mV/div	0.16 mV	0.16 mV
	5 mV/div	0.14 mV	0.18 mV
	10 mV/div	0.24 mV	0.29 mV
	20 mV/div	0.44 mV	0.54 mV
	50 mV/div	1.07 mV	1.4 mV
	100 mV/div	2.1 mV	2.7 mV
	200 mV/div	4.3 mV	5.2 mV
	500 mV/div	10.8 mV	13.3 mV
	1 V/div	21.5 mV	26.8 mV

Horizontal system

Time base range		selectable between 25 ps/div and 50 s/div, time per div settable to any value within range
Channel deskew		±100 ns
Reference position		10 % to 90 % of measurement display area
Trigger offset range	max.	+(memory depth/current sampling rate)
	min.	–10000 s
Modes		normal, roll
Channel-to-channel skew		< 100 ps (meas.)
Time base accuracy	standard	
	after delivery/calibration, at +23 °C	±5 ppm
	in calibration interval	±25 ppm
	with R&S®RTO-B4 option	
	after delivery/calibration, at +23 °C	±0.02 ppm
	in calibration interval	±0.2 ppm

Acquisition system

Realtime sampling rate	max.	10 Gsample/s on each channel
Realtime waveform acquisition rate	max.	>1000000 waveforms/s
Memory depth	standard	
	R&S®RTO1012, R&S®RTO1022	20 Msample on 2 channels, 40 Msample on 1 channel
	R&S®RTO1014, R&S®RTO1024	20 Msample on 4 channels, 40 Msample on 2 channels, 80 Msample on 1 channel
	R&S®RTO-B101 option	
	R&S®RTO1012, R&S®RTO1022	50 Msample on 2 channels, 100 Msample on 1 channel
	R&S®RTO1014, R&S®RTO1024	50 Msample on 4 channels, 100 Msample on 2 channels, 200 Msample on 1 channel
	R&S®RTO-B102 option	
	R&S®RTO1012, R&S®RTO1022	100 Msample on 2 channels, 200 Msample on 1 channel
	R&S®RTO1014, R&S®RTO1024	100 Msample on 4 channels, 200 Msample on 2 channels, 400 Msample on 1 channel
Decimation modes	sample	first sample in decimation interval
	peak detect	largest and smallest sample in decimation interval
	high resolution	average value of samples in decimation interval
	root mean square	root of squared average of samples in decimation interval

Waveform arithmetic	OFF	no arithmetic
	envelope	envelope of acquired waveforms
	average	average of acquired waveforms, max. average depth depending on decimation mode [1]
	sample	max. 16777215
	high resolution	max. 65535
	root mean square	max. 255
	reset condition	no reset (standard), reset by time, reset by number of processed waveforms
Waveform streams per channel		up to 3 with independent selection of decimation mode and waveform arithmetic
Sampling modes	real time mode	max. sampling rate set by digitizer
	interpolated time	enhancement of sampling resolution by interpolation; max. equivalent sampling rate is 4 Tsample/s
	equivalent time	enhancement of sampling resolution by repetitive acquisition; max. equivalent sampling rate is 4 Tsample/s
Interpolation modes		linear, sin(x)/x and sample & hold
Ultra segmented mode		continuous recording of waveforms in acquisition memory without interruption due to visualization, blind time between consecutive acquisitions less than 300 ns

Trigger system

Sources	R&S®RTO1012, R&S®RTO1022	channel 1, channel 2
	R&S®RTO1014, R&S®RTO1024	channel 1, channel 2, channel 3, channel 4
Sensitivity	trigger hysteresis mode	auto (standard) or manual
	range	0 V to 5 div × input sensitivity
Trigger jitter	full-scale sine wave of frequency set to –3 dB bandwidth	< 1 ps (RMS) (meas.)
Coupling mode	standard	like selected channel
	lowpass filter	cutoff frequency selectable from 100 kHz to 50 % of analog bandwidth
Sweep mode		auto, normal, single, n single
Trigger rearm time	max.	400 ps
Trigger level	range	±5 div from center of screen
Holdoff range	time	100 ns to 10 s, fixed and random
	events	1 event to 2000000000 events

Main trigger modes		
Edge	triggers on specified slope (positive, negative, or either) and level	
Glitch	triggers on glitches of positive, negative or either polarity that are shorter or longer than specified width	
	glitch width	100 ps to 1000 s
Width	triggers on positive or negative pulse of specified width; width can be shorter, longer, inside or outside the interval	
	pulse width	100 ps to 1000 s
Runt	triggers on pulse of positive, negative, or either polarity that crosses one threshold but fails to cross a second threshold before crossing the first one again; runt pulse width can be arbitrary, shorter, longer, inside or outside the interval.	
	runt pulse width	100 ps to 1000 s
Window	triggers when signal enters or exits a specified voltage range; triggers also when signal stays inside or outside the voltage range for a specified period of time	
Timeout	triggers when signal stays high, low or unchanged for a specified period of time	
	timeout	100 ps to 1000 s
Interval	triggers when time between two consecutive edges of same slope (positive or negative) is shorter, longer, inside or outside a specified range	
	interval time	100 ps to 1000 s

[1] Waveform average is not compatible with peak detect decimation.

Slew rate	triggers when the time required by a signal edge to toggle between user-defined upper and lower voltage levels is shorter, longer, inside or outside the interval; edge slope may be positive, negative or either	
	toggle time	100 ps to 1000 s
Data2clock	Triggers on setup time and hold time violations between clock and data present on any two input channels. The monitored time interval may be specified by the user in the range from –100 ns to 100 ns around a clock edge and must be at least 100 ps wide.	
Pattern	triggers when a logical combination (AND, NAND, OR, NOR) of the input channels stays true for a period of time shorter, longer, inside or outside a specified range	
Serial pattern	triggers on serial data pattern up to 128 bit long clocked by one input channel; pattern bits may be high (H), low (L), or don't care (X); clock edge slope may be positive, negative or either	
	max. data rate	2.50 Gbps

Advanced trigger modes		
Trigger qualification	Trigger events may be qualified by a logical combination of unused channels.	
	qualifiable events	edge, glitch, width, runt, window, timeout, interval
Sequence trigger (A/B/R trigger)	triggers on B event after occurrence of A event; delay condition after A event specified either as time interval or number of B events; an optional R event resets the trigger sequence to A	
	A event	any trigger mode
	B event	edge
	R event	edge, glitch, width, runt, window, timeout, interval, slew rate
Serial bus trigger	basic	I^2C, SPI, UART/RS-232
	optional	LIN, CAN, and FlexRay with dedicated software options

External trigger input	input impedance	50 Ω ± 1.5 % or 1 MΩ ± 1 % with 12 pF (meas.)
	max. input voltage	100 V DC, derates at 20 dB/decade to 5 V (RMS)
	trigger level	± 5 V
	sensitivity	< 300 mV (V_p)
	input coupling	AC, DC (50 Ω and 1 MΩ), GND, HF reject (attenuates > 50 kHz or > 50 MHz, user-selectable), LF reject (attenuates < 5 kHz or < 50 kHz, user-selectable)
	trigger modes	edge (rise or fall)

Waveform measurements

General features	measurement panels	up to 8 measurement panels; each panel may contain any number of automatic measurements of the same category
	gate	delimits the display region evaluated for automatic measurements
	reference levels	user-configurable vertical levels define support structures for automatic measurements
	statistics	displays maximum, minimum, mean, standard deviation, RMS, and measurement count for each automatic measurement
	long-term analysis	history of selected measurements as trace against count index
	limit check	measurements tested against user-defined margins and limits; pass or fail conditions may launch automatic response including acquisition stop

Measurement category	amplitude and time	amplitude, high, low, maximum, minimum, peak-to-peak, mean, RMS, sigma, overshoot, area, rise time, fall time, positive width, negative width, period, frequency, duty cycle, delay, phase, burst width, pulse count, positive switching, negative switching, cycle area, cycle mean, cycle RMS, cycle sigma, DC voltmeter (requires Rohde & Schwarz active probe with R&S®ProbeMeter functionality)
	eye diagram	extinction ratio, eye height, eye width, eye top, eye base, Q factor, S/N ratio, duty cycle distortion, eye rise time, eye fall time, eye bit rate, eye amplitude, jitter (peak-to-peak, 6-sigma, RMS)
	spectrum	channel power, bandwidth, occupied bandwidth, total harmonic distortion
Cursors	setup	up to 4 cursor sets on screen, each set consisting of two horizontal and two vertical cursors
	target	acquired waveforms (input channels), math waveforms, reference waveforms, XY diagrams
	operating mode	vertical measurements, horizontal measurements, or both; vertical cursors may stay fixed or track waveform
Histogram	source	acquired waveform (input channels), math waveform, reference waveform
	mode	vertical (for timing statistics), horizontal (for amplitude statistics)
	automatic measurements	waveform count, waveform samples, histogram samples, histogram peak, peak value, maximum, minimum, median, range, mean, sigma, mean ± 1, 2, and 3 sigma, marker ± probability

Mask testing

Test definition	number of masks	up to 8 simultaneously
	source	acquired waveforms (input channels), math waveforms
	fail condition	sample hit or waveform hit
	fail tolerance	minimum number of fail events for test fail in range from 0 to 4000000000
	test rate	up to 300000 waveforms per second
	action on error	acquisition stop
	save/load to file	test and mask settings (.xml format)
Mask definition	number of independent segment	up to 16
	segment definition	array of points and connecting rule (upper, lower, inner) define segment region
	segment input	point and click on touch screen, editable list
Result statistics	category	completed acquisitions, remaining acquisitions, state, sample hits, mask hits, fail rate, test result (pass or fail)
Visualization options	waveform style	vectors, dots
	violation highlighting	hits (ON/OFF), highlight persistence (50 ms to 50 s or infinite), waveform color (default: red)
	mask colors	configurable colors for mask without violation (default: translucent gray), mask with violation (default: translucent red), mask with contact (default: translucent pale red)

Waveform math

General features	number of math waveforms	up to 4
	number of reference waveforms	up to 4
	waveform arithmetic	user-selectable average or envelope of consecutive waveforms
Algebraic expressions	user may define complex mathematical expressions involving waveforms and measurement results	
	math functions	add, subtract, multiply, divide, absolute value, square, square root, integrate, differentiate, $\log_{10}$, $\log_e$, $\log_2$, rescale, sin, cos, tan, arcsin, arccos, arctan, sinh, cosh, tanh, autocorrelation, crosscorrelation
	logical operators	not, and, nand, or, nor, xor, nxor
	relational operators	Boolean result of =, ≠, >, <, ≤, ≥
	frequency domain	spectral magnitude and phase, real and imaginary spectra, group delay
	digital filter	lowpass, highpass
Optimized math	operators	add, subtract, multiply, invert, absolute value, differentiate, $\log_{10}$, $\log_e$, $\log_2$, rescale, FIR, FFT magnitude
Spectrum analysis	FFT magnitude spectrum	
	setup parameters	center frequency, frequency span, frame overlap, frame window (rectangular, Hamming, Hann, Blackman, Gaussian, Flattop, Kaiser Bessel), user-selectable spectrum averaging and envelope

Search and mark function

General description	scans acquired waveforms for occurrence of a user-defined set of events and highlights each occurrence	
Basic setup	source	all physical input channels, math waveforms, reference waveforms
	search panels	up to 8, where each panel may manage multiple event searches
	search mode	manually triggered or continuous
	search conditions	
	supported events	edge, glitch, width, runt, window, timeout, interval, slew rate, data2clock, state
	event configuration	identical to corresponding trigger event
	event selection	single or multiple events on same source
Search scope	mode	current waveform, gated time interval, history buffer
Result visualization	table	
	sort mode	horizontal position or vertical value
	max. result count	specifies max. table size
	zoom window	centered on highlighted event

Display characteristics

Diagram types	Yt, XY, spectrum, long-term measurement
Display interface configuration	Display area can be split up into separate diagram areas by dragging and dropping signal icons. Each diagram area can hold any number of signals. Diagram areas may be stacked on top of each other and later accessed via the dynamic tab menu.
Signal bar	Accommodates time base settings, trigger settings and signal icons. Signal bar may be docked to left or right side of display area, or hidden.
Signal icon	Each active waveform is represented by a separate signal icon on the signal bar. The signal icon displays the individual vertical and acquisition settings. A waveform can be minimized to its signal icon so that it appears as a realtime preview in miniature form. Dialog boxes and measurement results may be minimized to a signal icon as well.
Axis label	X-axis ticks and Y-axis ticks labeled with tick value and physical unit
Diagram label	Diagrams may be individually labeled with a descriptive custom-defined name.
Diagram layout	Grid, crosshair, axis labels and diagram label may be switched on and off separately.
Persistence	50 ms to 50 s, or infinite

Zoom	User-defined zoom window provides vertical and horizontal zoom. Each diagram area supports multiple zoom windows. Touch-screen interface simplifies resize of and drag operations on zoom window.
Signal colors	predefined or user-defined color tables for persistence display

Input and output

Front		
Channel inputs		BNC-compatible, for details see "Vertical system"
	probe interface	auto-detection of passive probes, Rohde & Schwarz active probe interface
Auxiliary output		SMA connector, for future use
Probe compensation output	signal shape	rectangle V_{low} = 0 V, V_{high} = 1 V (meas.)
	frequency	1 kHz ± 1 %
	impedance	50 Ω (nom.)
Ground jack		connected to ground
USB interface		2 ports, type A plug, version 2.0

Rear		
External trigger input		BNC, for details see "Trigger system"
USB interface		2 ports, type A plug, version 2.0
LAN interface		RJ-45 connector, supports 10/100/1000BaseT
External monitor interface		DVI-D connector, output of scope display or extended desktop display
GPIB interface		see R&S®RTO-B10 option
Reference input		see R&S®RTO-B4 option
Reference output		see R&S®RTO-B4 option
Security slot		for standard Kensington style lock

General data

Display	type	10.4" LC TFT color display with touch screen
	resolution	1024 × 768 pixel (XGA)

Temperature		
Temperature loading	operating temperature range	+0 °C to +45 °C
	storage temperature range	–40 °C to +70 °C
Climatic loading		+40 °C at 85 % rel. humidity, in line with IEC 60068-2-30

Altitude		
Operating		up to 3000 m above sea level
Non-operating		up to 4600 m above sea level

Mechanical resistance		
Vibration	sinusoidal	5 Hz to 150 Hz, max. 2 g at 55 Hz; 0.5 g from 55 Hz to 150 Hz; in line with EN 60068-2-6
	random	10 Hz to 300 Hz, acceleration 1.2 g (RMS), in line with EN 60068-2-64
Shock		40 g shock spectrum, in line with MIL-STD-810E method no. 516.4 procedure I

EMC		
RF emission	In line with EN 55011 class A, operation in residential, commercial and business areas or in small-size companies is not covered. Thus, the instrument may not be operated in residential, commercial and business areas or in small-size companies, unless additional measures are taken to ensure that EN 55011 class B is complied with.	in line with CISPR 11/EN 55011 group 1 class A (for a shielded test setup) The instrument complies with the emission requirements stipulated by EN 55011, EN 61326-1 and EN 61326-2-1 class A. This means that the instrument is suitable for use in industrial environments.
Immunity		in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environment [2]

Certifications		VDE-GS, $_{C}$CSA$_{US}$

Calibration interval		1 year

Power supply		
AC supply		100 V to 240 V at 50 Hz to 60 Hz and 400 Hz, max. 5.5 A to 2.3 A, in line with MIL-PRF28800F
Power consumption		max. 450 W
Safety		in line with IEC 61010-1, EN 61010-1, CAN/CSA-C22.2 No. 61010-1-04, UL 61010-1

Mechanical data		
Dimensions	W × H × D	427 mm × 249 mm × 204 mm (16.81 in × 9.80 in × 8.03 in)
Weight	without options, nominal	9.6 kg (21.16 lb)

[2] Test criterion is displayed noise level within ±1 div for input sensitivity of 5 mV/div.

Options

R&S®RTO-B4

OCXO, precision reference frequency with reference input and output connectors		
Time base accuracy	OCXO	see "Horizontal system"
Reference output	connector	BNC female
	impedance	50 Ω (nom.)
	output frequency with OCXO	10 MHz (nom.)
	output frequency with auxiliary reference	same as auxiliary reference
	level	> 7 dBm (nom.)
Auxiliary reference input	connector	BNC female
	impedance	50 Ω (nom.)
	input frequency range	1 MHz ≤ f_{in} ≤ 20 MHz, in 1 MHz steps
	required level	≥ 0 dBm into 50 Ω

R&S®RTO-B10

GPIB additional interface		
Function		interface in line with IEC 625-2 (IEEE 488.2)
Command set		SCPI 1999.0
Connector		24-pin Amphenol female
Interface functions		SH1, AH1, T6, L4, SR1, RL1, PP1, DC1, DT1, C0

R&S®RTO-B19

Additional removable hard disk		
Disk type		hard disk
Disk size		> 40 Gbyte (nom.)
Firmware		installed upon delivery

R&S®RTO-K1

I²C decoding		
Protocol configuration	bit rate	up to 3.4 Mbps (auto-detected)
	auto-setup	automatic configuration of scope for I²C trigger and decoding
Trigger (included in standard equipment)	source (clock and data)	any input channel
	trigger event setup	start, stop, restart, missing ACK, address, data, address + data
	address setup	7 bit or 10 bit (value in hex or binary); ACK, NACK or either; read, write or either; R/W bit included in address value or apart; condition =, ≠, ≥, ≤, in range, out of range
	data setup	data pattern up to 8 byte long (hex or binary); condition =, ≠; offset within frame in range from 0 byte to 4095 byte
Decode	source (clock and data)	any input channel, math waveform, reference waveform
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	frame, start/restart, address, R/W bit, data, ACK/NACK, stop, error
	address and data format	hex, binary; symbolic names for user-defined subset of addresses

SPI decoding		
Protocol configuration	type	2-wire, 3-wire, and 4-wire SPI
	bit rate	up to 50 Mbps (auto-detected)
	bit order	LSB first, MSB first
	word size	4 bit to 32 bit
	frame condition	SS, timeout
	polarity (MOSI, MISO, SS, CLK)	active high, active low
	phase (CLK)	first edge, second edge
	auto-setup	automatic configuration of scope for SPI trigger and decoding
Trigger (included in standard equipment)	source (MOSI, MISO, SS, CLK)	any input channel
	trigger event setup	frame start, MOSI, MISO, MOSI + MISO
	data setup	data pattern up to 256 bit long (hex or binary); condition =, ≠; offset within frame in range from 0 bit to 32767 bit
Decode	source (MOSI, MISO, SS, CLK)	any input channel, math waveform, reference waveform
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	frame, word, error
	data format	hex, binary

R&S®RTO-K2

UART decoding		
Protocol configuration	bit rate	300 bps to 10 Mbps
	signal polarity	idle low, idle high
	number of bits	5 bit to 9 bit
	bit order	LSB first, MSB first
	parity	odd, even, mark, space, none
	stop bit	1, 1.5, or 2 bit periods
	end of packet	word, timeout, none
	auto-setup	automatic configuration of scope for UART trigger and decoding
Trigger (included in standard equipment)	source (TX and RX)	any input channel
	trigger event setup	start bit, packet start, data, parity error, break condition
	data setup	data pattern up to 256 bit long (hex or binary); condition =, ≠; offset within packet in range 0 bit to 32767 bit
Decode	source (TX and RX)	any input channel, math waveform, reference waveform
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	packet, data payload, start error, parity error, stop error
	data format	hex, binary

R&S®RTO-K3

CAN trigger and decoding		
Protocol configuration	signal type	CAN_H, CAN_L, differential
	bit rate	100 bps to 1 Mbps
	sampling point	5 % to 95 % within bit period
	device list	associate frame identifier with symbolic ID
	auto-setup	automatic configuration of scope for CAN trigger and decoding
Trigger	source	any input channel
	trigger event setup	start of frame, frame type, identifier, identifier + data, error condition (any combination of CRC error, bit stuffing error, form error and ACK error)
	identifier setup	frame type (data, remote or both), identifier type (standard or extended); condition =, ≠, ≥, ≤, in range, out of range
	data setup	data pattern up to 8 byte long (hex or binary); condition =, ≠; offset within frame in range from 0 byte to 7 byte
Decode	source	any input channel, math waveform, reference waveform
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	start of frame, identifier, DLC, data payload, CRC, end of frame, error frame, overload frame, CRC error, bit stuffing error
	data format	hex, binary

LIN trigger and decoding		
Protocol configuration	version	1.3, 2.x, or SAE J602; mixed traffic is supported
	bit rate	standard bit rate (1.2/2.4/4.8/9.6/10.417/ 19.2 kbps) or user-defined bit rate in range from 1 kbps to 20 kbps
	device list	associate frame identifier with symbolic ID, data length, and protocol version
	auto-setup	automatic configuration of scope for LIN trigger and decoding
Trigger	source	any input channel
	trigger event setup	start of frame (sync break), identifier, identifier + data, wakeup frame, error condition (any combination of checksum error, parity error, and sync field error)
	identifier setup	range from 0d to 63d; select condition =, ≠, ≥, ≤, in range, out of range for trigger “identifier”; select single identifier and condition = for trigger “identifier + data”
	data setup	data pattern up to 8 byte (hex or binary); condition =, ≠, ≥, ≤, in range, out of range; offset within frame in range from 0 byte to 7 byte
Decode	source (TX and RX)	any input channel, math waveform, reference waveform
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	frame, frame identifier, data payload, checksum, error condition
	data format	hex, binary

Ordering information

Designation	Type	Order No
Base unit (accessories supplied: 500 MHz passive voltage probe 10:1 per channel, accessory pouch, front cover, quick start manual, power cord)		
Digital Oscilloscope		
1 GHz, 2 channels	R&S®RTO1012	1304.6002.12
1 GHz, 4 channels	R&S®RTO1014	1304.6002.14
2 GHz, 2 channels	R&S®RTO1022	1304.6002.22
2 GHz, 4 channels	R&S®RTO1024	1304.6002.24
Hardware options (plug-in options)		
OCXO, accurate 10 MHz reference	R&S®RTO-B4	1304.8305.02
GPIB Interface	R&S®RTO-B10	1304.8311.02
Hard Disk for exchange incl. firmware	R&S®RTO-B19	1304.8328.02
Sample memory upgrade		
Memory Upgrade, 50 Msample per channel	R&S®RTO-B101	1304.8411.02
Memory Upgrade, 100 Msample per channel	R&S®RTO-B102	1304.8428.02
Software options		
I^2C/SPI Trigger and Decoding	R&S®RTO-K1	1304.8511.02
UART/RS-232 Trigger and Decoding	R&S®RTO-K2	1304.8528.02
CAN/LIN Trigger and Decoding	R&S®RTO-K3	1304.8534.02
FlexRay Trigger and Decoding	R&S®RTO-K4	1304.8540.02
Probes		
500 MHz, passive, 10:1	R&S®RT-ZP10	1409.7550.00
1.5 GHz, active voltage probe, single-ended	R&S®RT-ZS20	1410.3502.02
3.0 GHz, active voltage probe, single-ended	R&S®RT-ZS30	1410.4309.02
1.5 GHz, active voltage probe, differential	R&S®RT-ZD20	1410.4409.02
3.0 GHz, active voltage probe, differential	R&S®RT-ZD30	1410.4609.02
Probe accessories		
Accessory Kit for R&S®RT-ZP10 Passive Voltage Probe	R&S®RT-ZA1	1409.7566.00
Spare Accessory Set for R&S®RT-ZS20/R&S®RT-ZS30	R&S®RT-ZA2	1416.0405.02
Pin Set for R&S®RT-ZS20/R&S®RT-ZS30	R&S®RT-ZA3	1416.0411.02
Mini Clips	R&S®RT-ZA4	1416.0428.02
Micro Clips	R&S®RT-ZA5	1416.0434.02
Lead Set	R&S®RT-ZA6	1416.0440.02
Accessories		
Front Cover	R&S®RTO-Z1	1304.9101.02
Rackmount Kit	R&S®ZZA-Sxxx	1304.8286.02
Soft Case	R&S®RTO-Z3	1304.9118.02

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